



# HML1225/HXL1225

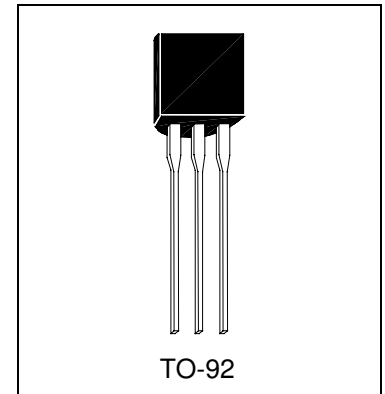
0.8A 300/380 VOLTAGE SCRS IGT<200uA

## Description

The HML1225/HXL1225 series silicon controlled rectifiers are high performance planner diffused PNP devices. These parts are intended for low cost high volume applications.

## Absolute Maximum Ratings ( $T_A=25^\circ\text{C}$ )

Parameter	Part No.	Symbol	Min	Max	Unit	Test Conditions
Repetitive Peak Off State Voltage	HXL1225	$V_{DRM}$	380	-	V	$T_J=40^\circ\text{C}$ to $125^\circ\text{C}$ ( $R_{GK}=1\text{K}$ )
	HML1225	$V_{DRM}$	300	-	V	
On-State Current		$I_{T(rms)}$	0.8	-	A	$T_C=40^\circ\text{C}$
Average On-State Current		$I_{T(AV)}$	0.5	-	A	Half Cycle= $180^\circ$ , $T_C=40^\circ\text{C}$
Peak Reverse Gate Voltage		$V_{GRM}$	8	-	V	$I_{GR}=10\mu\text{A}$
Peak Gate Current		$I_{GM}$	1	-	A	10us max
Gate Dissipation		$P_{G(AV)}$	0.1	-	W	20ms max
Operating Temperature		$T_J$	-40	125	$^\circ\text{C}$	
Storage Temperature		$T_{stg}$	-40	125	$^\circ\text{C}$	
Soldering Temperature		$T_{sld}$	-	250	$^\circ\text{C}$	1.6mm from case 10s max



## Classification Of IGT

Rank	AA	AB	AC	AD	B	C
HML1225	10-18 $\mu\text{A}$	12-23 $\mu\text{A}$	17-28 $\mu\text{A}$	22-55 $\mu\text{A}$	45-105 $\mu\text{A}$	-
HXL1225	10-18 $\mu\text{A}$	12-23 $\mu\text{A}$	17-28 $\mu\text{A}$	22-55 $\mu\text{A}$	45-105 $\mu\text{A}$	95-155 $\mu\text{A}$

## Electrical Characteristics ( $T_A=25^\circ\text{C}$ )

Parameter	Symbol	Min	Max	Unit	Test Conditions
Off-State Leakage Current	$I_{DRM}$	-	0.1	$\text{mA}$	@ $V_{DRM}$ ( $R_{GK}=1\text{K}$ ), $T_J=125^\circ\text{C}$
Off-State Leakage Current	$I_{DRM}$	-	5	$\mu\text{A}$	@ $V_{DRM}$ ( $R_{GK}=1\text{K}$ ), $T_J=25^\circ\text{C}$
On-State Voltage	$V_T$	-	1.4	V	@ $I_T=0.4\text{A}$ , $T_J=25^\circ\text{C}$
		-	2.2	V	@ $I_T=0.8\text{A}$ , $T_J=25^\circ\text{C}$
On-State Threshold Voltage	$V_{T(TO)}$	-	0.95	V	$T_J=125^\circ\text{C}$
On-State Slops Resistance	$r_T$	-	600	Ohm	$T_J=125^\circ\text{C}$
Gate Trigger Current	$I_{GT}$	-	200	$\mu\text{A}$	$V_D=7\text{V}$
Gate Trigger Voltage	$V_{GT}$	-	0.8	V	$V_D=7\text{V}$
Holding Current	$I_H$	-	5	$\text{mA}$	$R_{GK}=1\text{K}(\text{ohm})$
Latching Current	$I_L$	-	6	$\text{mA}$	$R_{GK}=1\text{K}(\text{ohm})$
Critical Rate of Voltage Rise	$dv/dt$	25	-	$\text{V/us}$	$V_D=0.67 \cdot V_{DRM}$ ( $R_{GK}=1\text{K}$ ), $T_J=125^\circ\text{C}$
Critical Rate of Current Rise	$di/dt$	30	-	$\text{A/us}$	$I_G=10\text{mA}$ , $diG/dt=0.1\text{A/us}$ , $T_J=125^\circ\text{C}$
Gate Controlled Delay Time	$t_{gd}$	-	500	ns	$I_G=10\text{mA}$ , $diG/dt=0.1\text{A/us}$
Commutated Turn-off Time	$t_g$	-	200	$\mu\text{s}$	$T_C=85^\circ\text{C}$ , $V_D=0.67 \cdot V_{DRM}$ $V_R=35\text{V}$ , $I_T=I_{T(AV)}$
Thermal Resistance junc.to case	$R_{\theta jc}$	100	-	K/W	
Thermal Resistance junc. to amb	$R_{\theta ja}$	200	-	K/W	



### TO-92 Dimension

3-Lead TO-92 Plastic Package  
HSMC Package Code: A

**Marking:**

Pb Free Mark  
 Pb-Free: "e" (Note)  
 Normal: None

Product Series (M,X)  
 H L  
 1 2 2 5

Date Code  
 Control Code

Note: Green label is used for pb-free packing

Pin Style: 1.Cathode 2.Gate 3.Anode

Material:

- Lead solder plating: Sn60/Pb40 (Normal), Sn/3.0Ag/0.5Cu or Pure-Tin (Pb-free)
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0

DIM	Min.	Max.
A	4.33	4.83
B	4.33	4.83
C	12.70	-
D	0.36	0.56
E	-	*1.27
F	3.36	3.76
G	0.36	0.56
H	-	*2.54
I	-	*1.27
$\alpha 1$	-	*5°
$\alpha 2$	-	*2°
$\alpha 3$	-	*2°

\*: Typical, Unit: mm

### TO-92 Taping Dimension

DIM	Min.	Max.
A	4.33	4.83
D	3.80	4.20
D1	0.36	0.53
D2	4.33	4.83
F1,F2	2.40	2.90
H	15.50	16.50
H1	8.50	9.50
H2	-	1
H2A	-	1
H3	-	27
H4	-	21
L	-	11
L1	2.50	-
P	12.50	12.90
P1	5.95	6.75
P2	50.30	51.30
T	-	0.55
T1	-	1.42
T2	0.36	0.68
W	17.50	19.00
W1	5.00	7.00

Unit: mm

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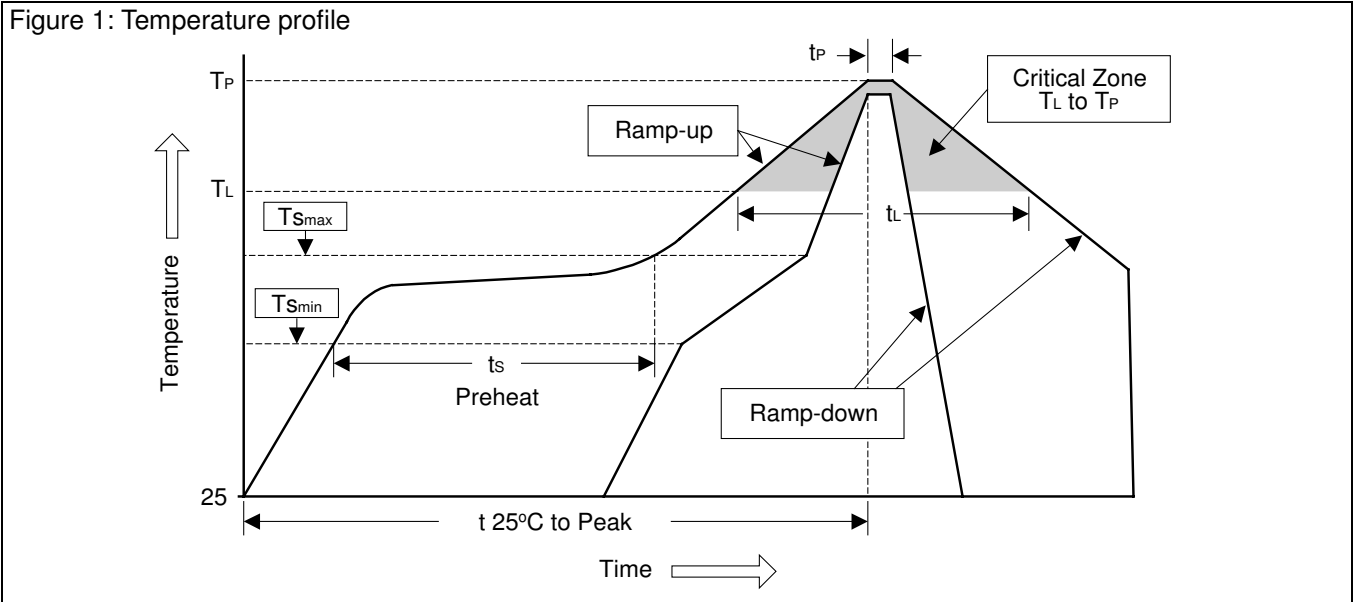
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### Soldering Methods for HSMC's Products

1. Storage environment: Temperature=10°C~35°C Humidity=65%±15%
2. Reflow soldering of surface-mount devices



Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Average ramp-up rate (T <sub>L</sub> to T <sub>p</sub> )	<3°C/sec	<3°C/sec
Preheat		
- Temperature Min (T <sub>smin</sub> )	100°C	150°C
- Temperature Max (T <sub>smax</sub> )	150°C	200°C
- Time (min to max) (ts)	60~120 sec	60~180 sec
T <sub>smax</sub> to T <sub>L</sub>		
- Ramp-up Rate	<3°C/sec	<3°C/sec
Time maintained above:		
- Temperature (T <sub>L</sub> )	183°C	217°C
- Time (t <sub>L</sub> )	60~150 sec	60~150 sec
Peak Temperature (T <sub>p</sub> )	240°C +0/-5°C	260°C +0/-5°C
Time within 5°C of actual Peak Temperature (t <sub>p</sub> )	10~30 sec	20~40 sec
Ramp-down Rate	<6°C/sec	<6°C/sec
Time 25°C to Peak Temperature	<6 minutes	<8 minutes

### 3. Flow (wave) soldering (solder dipping)

Products	Peak temperature	Dipping time
Pb devices.	245°C ±5°C	5sec ±1sec
Pb-Free devices.	260°C +0/-5°C	5sec ±1sec